

# INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(PTO-1449)

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60188-831SERIAL NO.  
10/820,055APPLICANT  
Kenji ORITAFILING DATE  
April 08, 2004GROUP  
2811

## U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
ca	B1	US 6,495,862	12/17/2002	Okazaki et al.	
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## FOREIGN PATENT DOCUMENTS

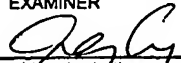
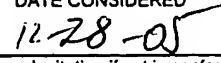
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes - Number - Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

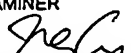
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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

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<b>FOREIGN PATENT DOCUMENTS</b>							
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						Yes	No
Ca		JP P2000-196152A	07/14/2000	TOSHIBA CORP		(Japan w/English Abstract)	
				/			
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
Ca		Hiroyuki ICHIKAWA, et al., "High Efficiency Light Emitting Diode with 2-D Surface Grating Photonic Crystal", Optical Society of America, 2002					
		/					
EXAMINER		DATE CONSIDERED					
		<b>12-28-05</b>					

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